Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/616,525	FUNK ET AL.	
Examiner	**Art Unit**	
J. Derek Rutten	2192	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PLUS database search EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	11/21/2006	JDR
Inventor Name search Rosenberg, "How Debuggers Work"	11/21/2006	JDR
717/129 - text search only See search history printout	11/21/2006	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	11/22/2006	JDR
717/127-130; 714/34,35 Text search only See search history printout	11/22/2006	JDR
Google - www.google.com ACM - www.acm.org See search history printout	11/22/2006	JDR
Tuan Dam (consulted re. 112 1st)	11/28/2006	**JDR**